


<b>Search Notes</b>  	<b>Application/Control No.</b>  10577482	<b>Applicant(s)/Patent Under Reexamination</b>  FUJITA ET AL.
	<b>Examiner</b>  RANDOLPH CHU	<b>Art Unit</b>  2624

SEARCHED			
Class	Subclass	Date	Examiner
382	274	12/31/2009	RIC
348	251, 254	12/31/2009	RIC
358	461	12/31/2009	RIC
345	20, 63, 77, 581-618, 596-599, 690-697	12/31/2009	RIC

SEARCH NOTES		
Search Notes	Date	Examiner
EAST	12/31/2009	ric
Inventor Name Search	12/31/2009	ric
NPL, Internet	12/31/2009	ric
Updated EAST Search	6/23/2010	ric
Updated EAST Search	7/8/2011	ric
Updated EAST Search	10/31/2011	ric
Updated NPL, Search	10/31/2011	ric

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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